

Search Notes



Application/Control No.

10/018,520

Examiner

Hien Tran

Applicant(s)/Patent under Reexamination

HAWKER, PELHAM NIGEL

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
422	171, 172, 177, 180	5/05	mr
60	274, 278, 280, 292		
123	568.12		
60	605.2, 602		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Image cl/sub search / mvs 'names search / Text search	5/05	mr